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# **W, Z measurements from early data with CMS**

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- Introduction
- Inclusive cross section measurements ( $e, \mu$ )
  - efficiency measurements
  - events selections and background estimation
  - acceptance studies
- Summary

# Introduction

- “**early data**” → assume an integrated luminosity  $\sim$  **10-100 pb<sup>-1</sup>**
  - instantaneous luminosity  $\sim 10^{32}$  cm<sup>-2</sup> s<sup>-1</sup>
- W, Z (→ leptons) measurements with early data
  - large and high purity samples thanks to the **high production cross section** and **clean experimental signature**

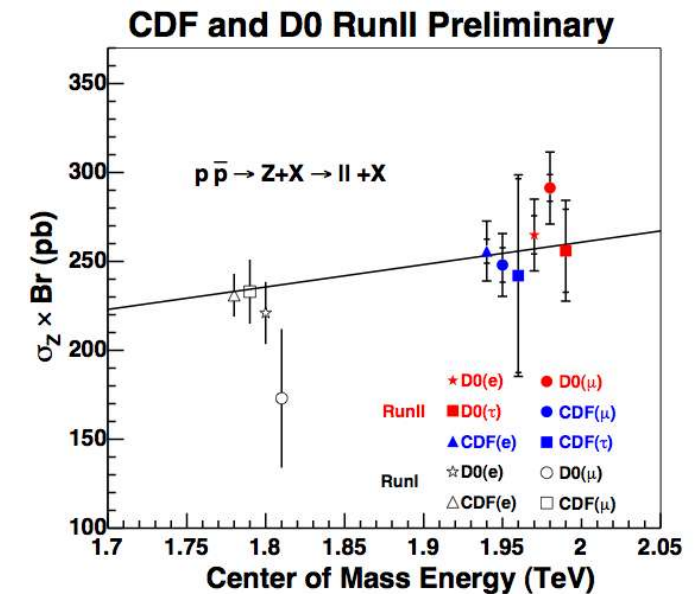
Process	$\sigma \times \text{Br}$ [pb]	$\epsilon \times A$ (estimate)	Events 10 pb <sup>-1</sup>
<b>Z → ll</b>	2000	25%	5000
<b>W → lv</b>	20000	35%	70000
ttbar → lv + X	370	1.5%	< 100
Jet E <sub>T</sub> > 25 GeV	3 · 10 <sup>9</sup>	100%	3 · 10 <sup>10</sup> x p.f.
Minimum bias	10 <sup>11</sup>	100%	10 <sup>12</sup> x p.f.

- “Standard candles” for detector calibration/understanding and first physics measurements
  - inclusive cross sections measurements
  - monitor collider luminosity
  - constrain Parton Distribution Functions (looking at  $\sigma_{\text{TOT}}$ , W rapidity,...)

# Inclusive cross section measurement

$$\sigma_{W(Z)} \times BR(W(Z) \rightarrow leptons) = \frac{N_{W(Z)}^{obs} - N_{W(Z)}^{bkg}}{\epsilon_{W(Z)} A_{W(Z)} \int \mathcal{L} dt}$$

- compare the measure to theory or reverse the relation for
  - luminosity measurement
  - constraining PDFs
- with large LHC datasets, main uncertainties are non-statistical
  - luminosity (5-7%), systematics (2-3%)  
[see also D0 Note 4750; arXiv:hep-ex/0508029]



- Efforts to define methods to measure most of the parameters from the data themselves and to minimize the dependence on MC
  - $\epsilon$  = trigger and offline lepton efficiencies  $\Rightarrow$  from data
  - $N^{bkg}$  = expected background  $\Rightarrow$  from data and MC
  - $A$  = acceptance  $\Rightarrow$  from MC

# Efficiency measurement from data

## The Tag&Probe method

- Use  $Z \rightarrow ee(\mu\mu)$  events to provide an unbiased, high purity electron (muon) sample to measure the efficiency of a particular selection

TAG : electron (muon) selected with tight criteria

PROBE : electron(muon) candidate with loose selections depending on the efficiencies under study

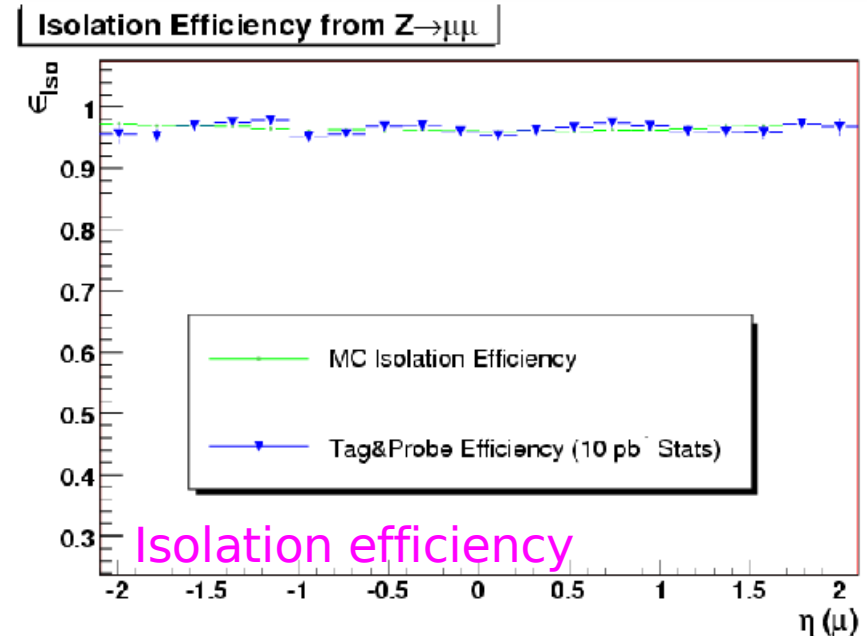
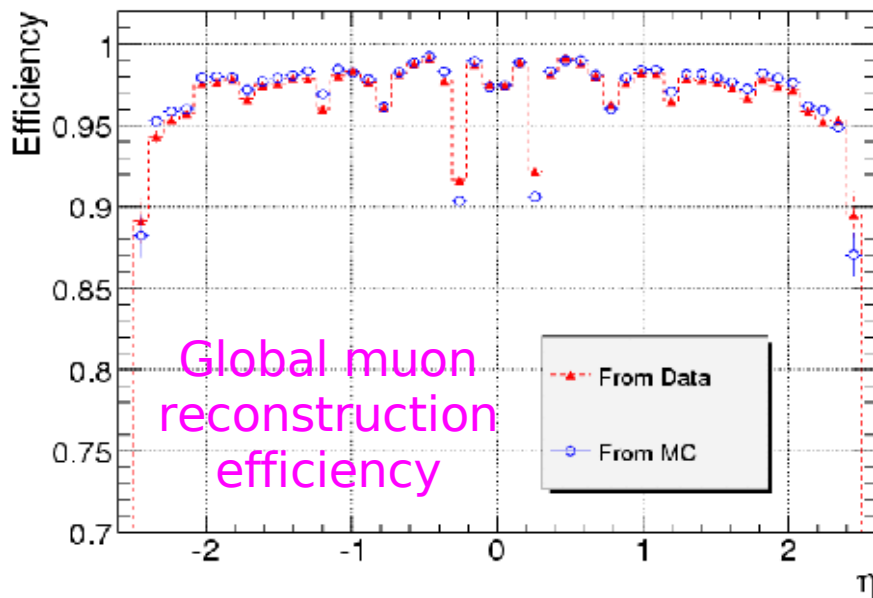
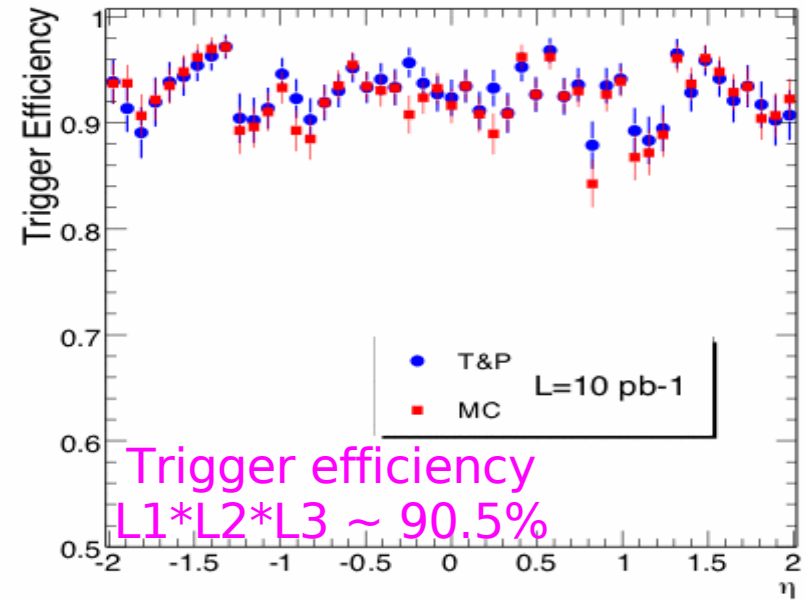
- tag-probe invariant mass within a narrow window around  $M(Z)$  + possible requirement on  $\Delta\Phi(\text{tag-probe})$
- tight tag selections + kinematic cuts to ensure a high purity sample

$$\epsilon = \frac{\# \text{ probes passing the selection}}{\# \text{ all probes}}$$

- map efficiencies as a function of  $p_T, \eta, \Phi$  for physics analysis
- critical issues of the method
  - residual background contamination (QCD, W+jets) to be subtracted
  - check of correlations and dependencies on the selections applied

# Muon efficiency with “Tag&Probe”

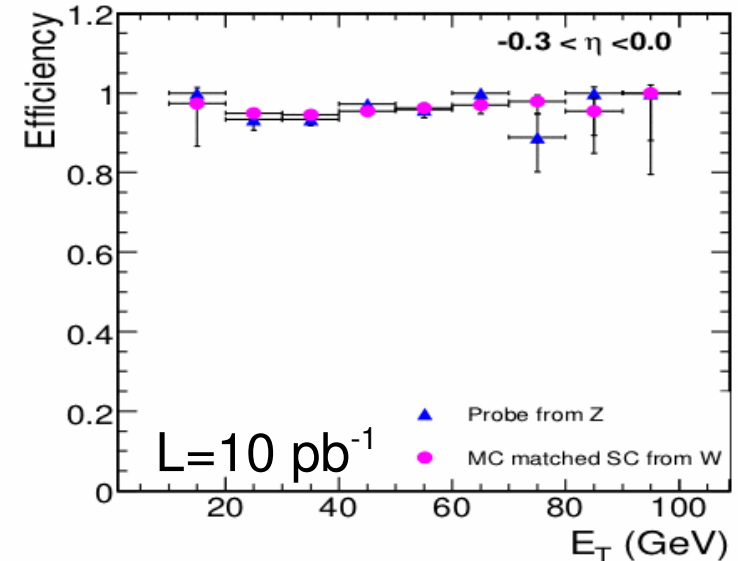
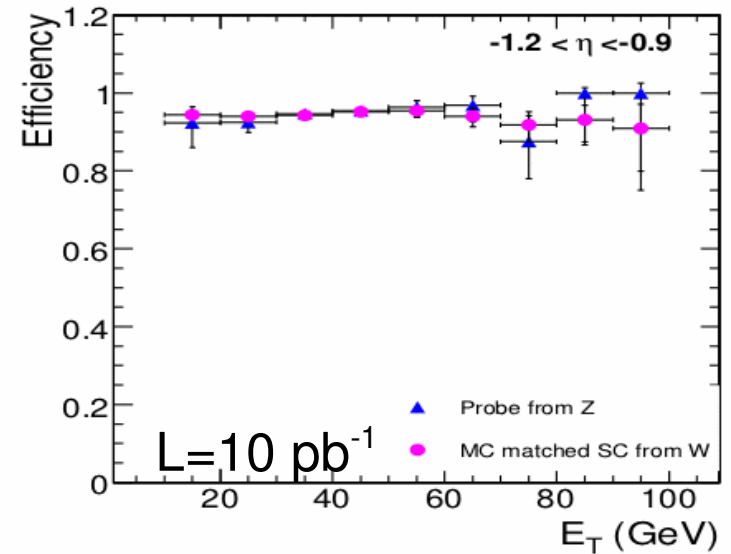
- $\epsilon = \epsilon_{\text{reco}} \times \epsilon_{\text{isolation}} \times \epsilon_{\text{trigger}}$   
 for muons:  $\epsilon_{\text{reco}} = \epsilon_{\text{tracking}} \times \epsilon_{\text{standalone}} \times \epsilon_{\text{matching}}$
- Example: measuring trigger efficiency
  - TAG: isolated global reconstructed muon,  $p^T > 20$  GeV, passing HLT
  - PROBE: isolated global reco. muon
  - $83.7 \text{ GeV} < M(\mu\mu) < 98.7 \text{ GeV}$
- overall precision on efficiency  $< 1\%$



# Efficiency: Tag&Probe vs $W \rightarrow l\nu$

- apply efficiency measured with  $Z \rightarrow ll$  to  $W \rightarrow l\nu$
- efficiency mapped in  $\mathbf{p}^T, \eta$  bins to account for *different kinematic distributions* of leptons from Z and W
- good agreement between “Tag&Probe” efficiency and MC truth in  $W \rightarrow l\nu$ 
  - from comparison between “Tag&Probe” efficiency and MC efficiency in  $W \rightarrow l\nu$  performed as a function of  $E^T$  and in  $\eta$  slices

Electron tracking efficiency



Tag: HLT electron,  $E^T > 15 \text{ GeV}$ , track isolation  
 Probe: ECAL SC,  $E^T > 20 \text{ GeV}$   
 $85 \text{ GeV} < M(\text{tag-probe}) < 95 \text{ GeV}$

# Events selection and backgrounds $Z \rightarrow \ell\ell$

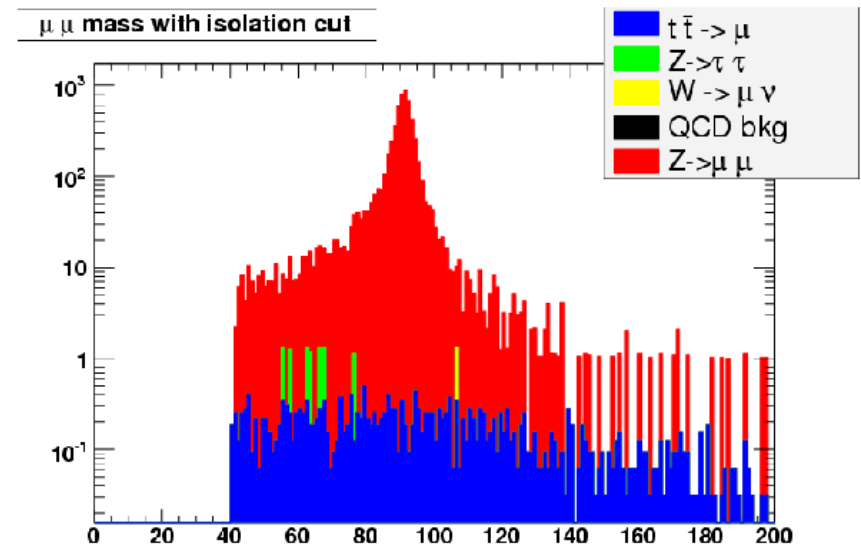
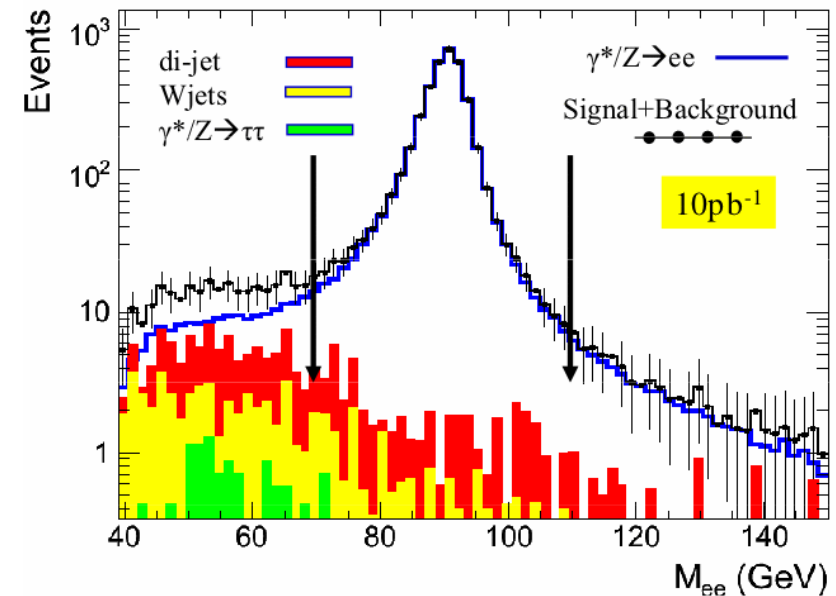
## ● Selections:

- two well reconstructed isolated leptons with opposite charge within detector acceptance ( $|\eta| < 2.4$ )
  - lepton ID based on simple but robust cuts
- high pt (well above trigger thresholds)
- invariant mass ( $70 \text{ GeV} < M < 110 \text{ GeV}$ )

## ● Main Backgrounds

- $Z \rightarrow \tau\tau$ ,  $t\bar{t}$ ,  $W$ +jets
- true or misidentified leptons from di-jet events

- almost negligible background contamination ( $\sim$  few %) after all selections





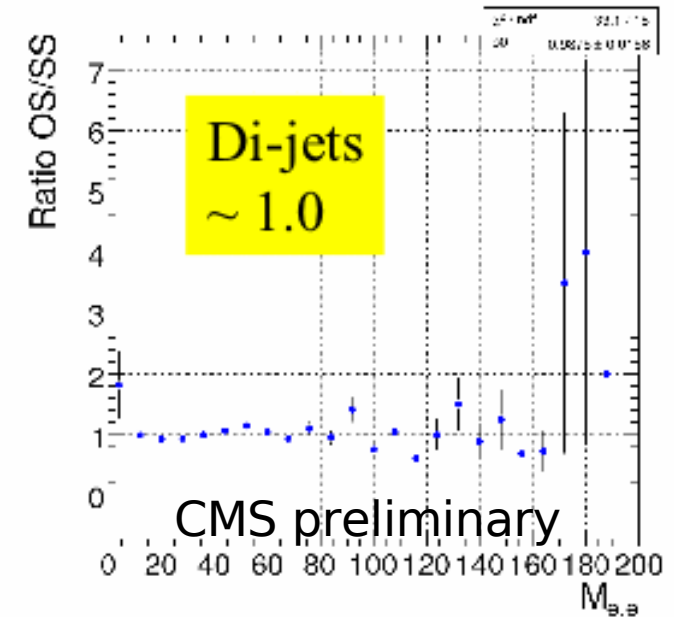
# Backgrounds from data in $Z \rightarrow ll$

- subtraction of residual background needed for a correct estimation of efficiencies with T&P and cross sections

## ***Different techniques under investigation***

### **(1) “Charge Correlation” Method**

- look at “same-sign”(SS) and “opposite-sign”(OS) events
- **$N(SS) = N(OS)$**  under the assumption of no charge correlation in lepton pairs from hadronic events
- need to take into account charge mismeasurement probability in signal and possible non-negligible charge correlations



### **(2) “Side Bands” Method**

### **(3) fit with background (or signal+bkg.) templates of a discriminating variable**

- more sophisticated, may require higher luminosities (i.e. with enough data to model background shapes)

**(1)** and **(2)** are simple but robust methods:

- desirable for a start-up scenario
- adequate for the level of background expected in  $\sim 10 \text{ pb}^{-1}$

# Events selection and backgrounds $W \rightarrow l\nu$

## ● Selections

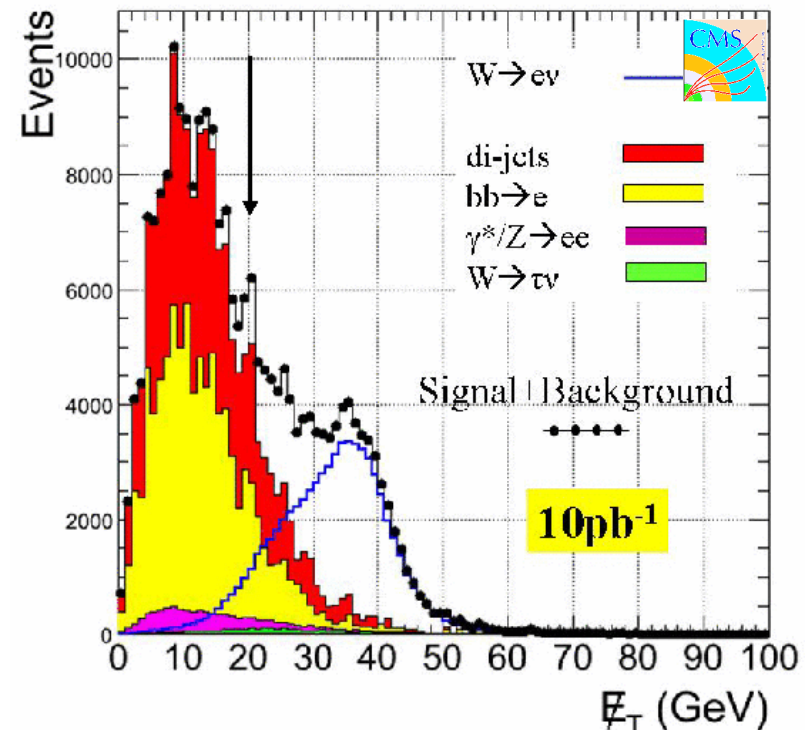
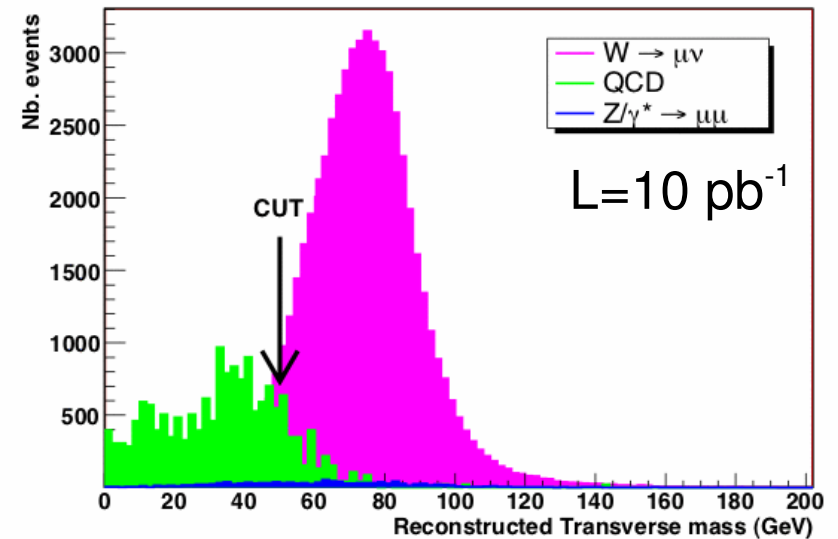
- one well reconstructed lepton within detector acceptance and passing HLT requirements
- lepton isolation
- lepton  $p^T > 20$  GeV
- transverse mass and/or MET cut + possible jet vetoes to reduce hadronic backgrounds

## ● Electroweak backgrounds

- $W \rightarrow \tau\nu$ ,  $Z/\gamma^* \rightarrow ll$ ,  $Z \rightarrow \tau\tau$ ,  $t\bar{t}$  ( $\sim$ few %)
- $WW$ ,  $WZ$ ,  $ZZ$  ( $\sim$ negligible)
- can be reliably estimated from MC simulation

## ● Hadronic backgrounds

- highest uncertainty
- can be estimated **from data**



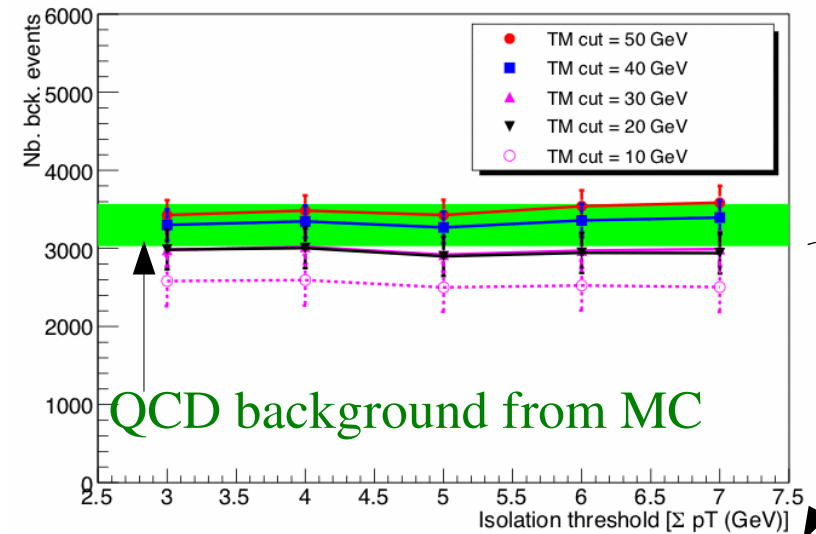
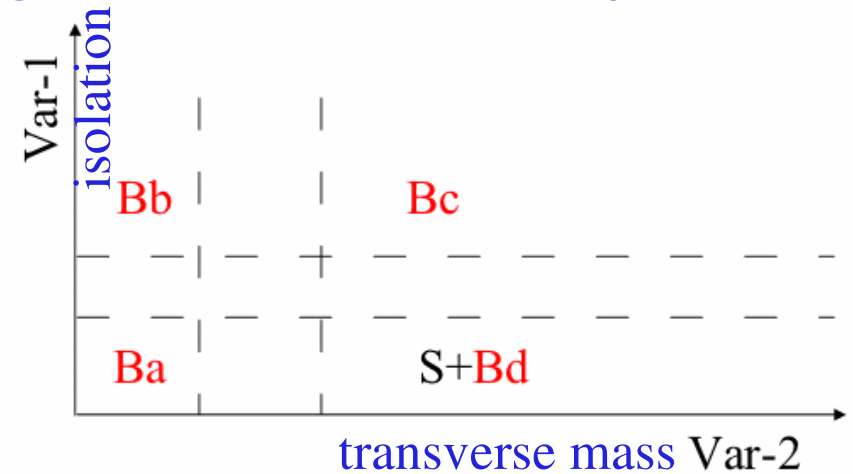
# Background estimation: "Matrix method"

General technique used by CDF and D0

- consider two variables with signal/background discrimination power
  - main assumption: the two variables are largely uncorrelated
  - e.g.: lepton isolation and MET(M<sup>T</sup>)
  - look at Var1%Var2
- Simplest approach: assuming that Ba, Bb, Bc are *only* QCD events, the number of bkg. events Bd in the signal region is deduced by the ratio R

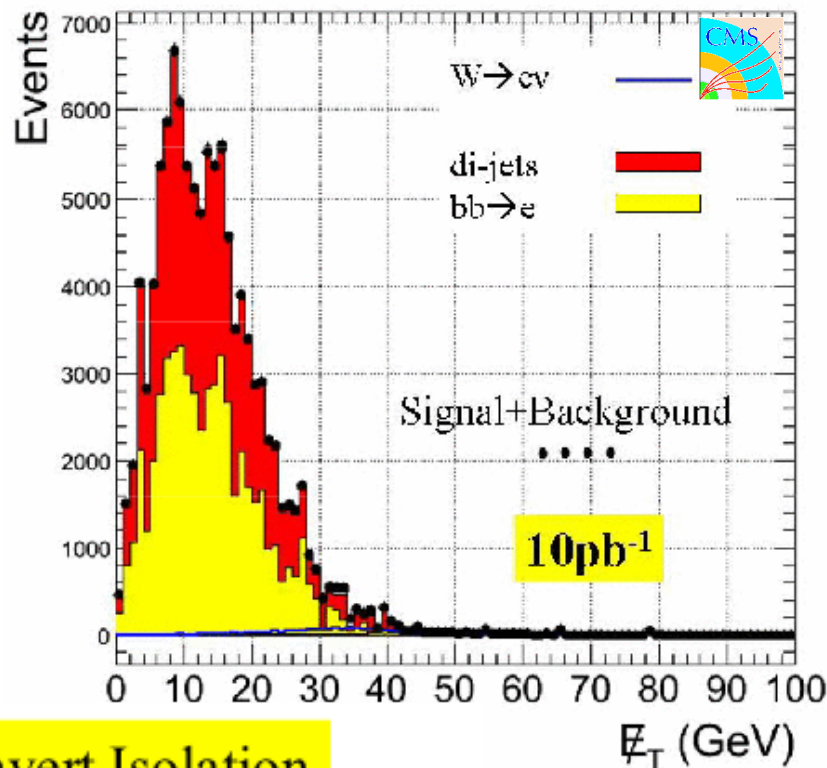
$$R = \frac{Bb}{Ba} = \frac{Bc}{Bd} \rightarrow Bd = \frac{Bc}{R}$$

- "non-QCD" contamination correction in regions a, b, c may be required
- systematics dominated by the validity of the assumption  $Bb/Ba = Bc/Bd$



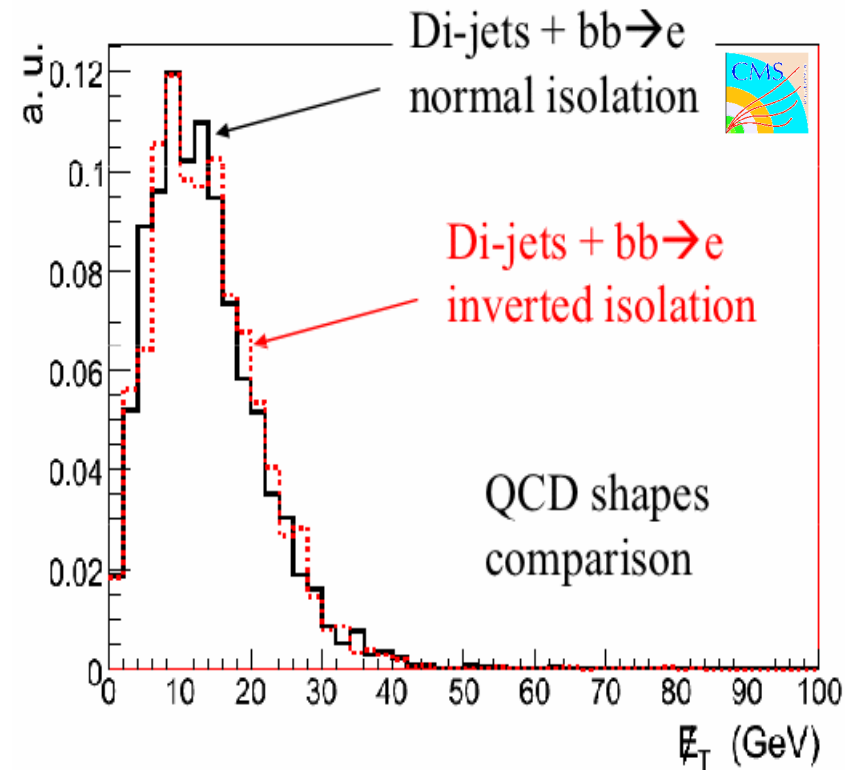
Results for QCD bkg estimation in  $W \rightarrow \mu\nu$  shown for different control regions using  $0.5 \text{ pb}^{-1}$

# Background estimation from data (I)



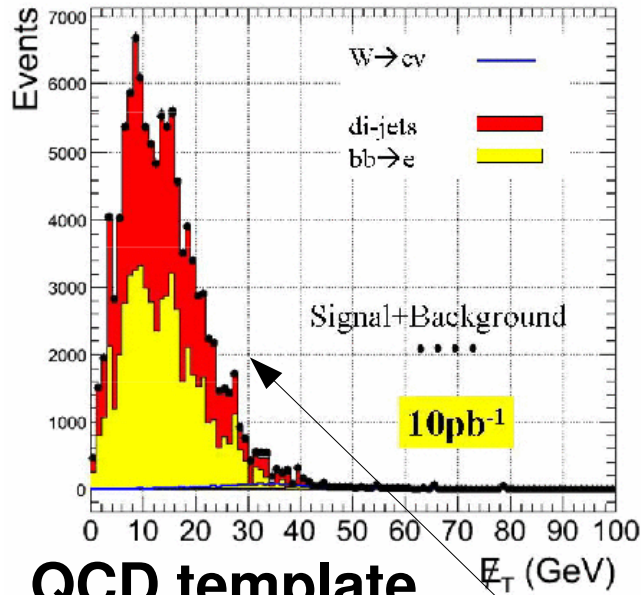
Invert Isolation

$$\sum_{track} \left( \frac{p_T^{track}}{p_T^{ele}} \right)^2 > 0.02$$



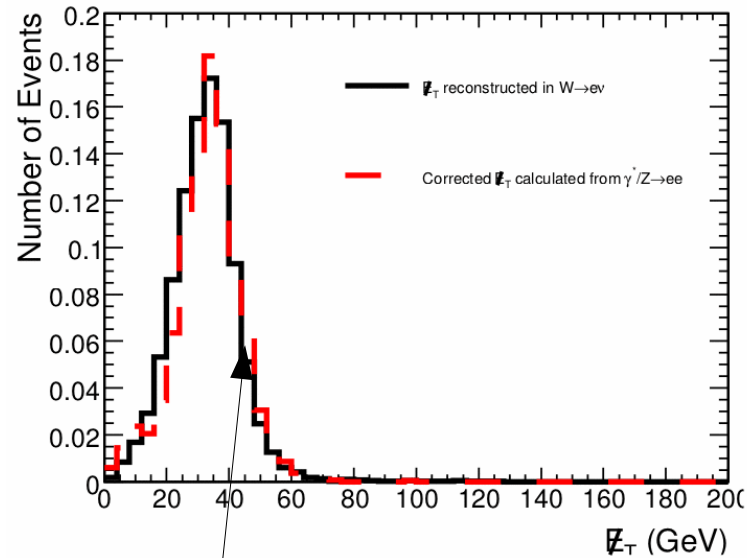
- MET distribution in QCD events is almost independent of whether the candidates pass or fail the isolation requirement
- it can then be modeled on ANTI-ISOLATED leptons

# Background estimation from data (II)



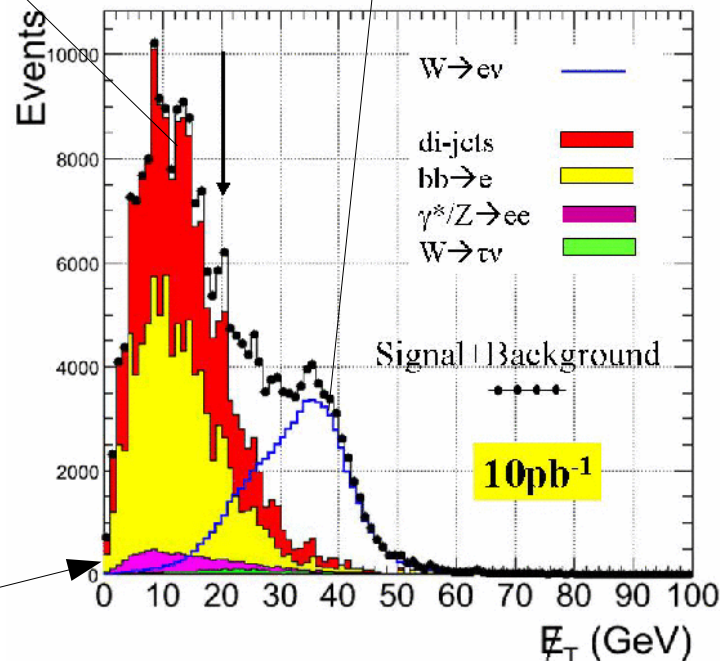
**QCD template**  
from anti-isolated  
electrons

Other  
backgrounds: use  
full simulation



## W→ev MET template from Z→ee

- ignore one lepton
- corrections for different W/Z kinematics

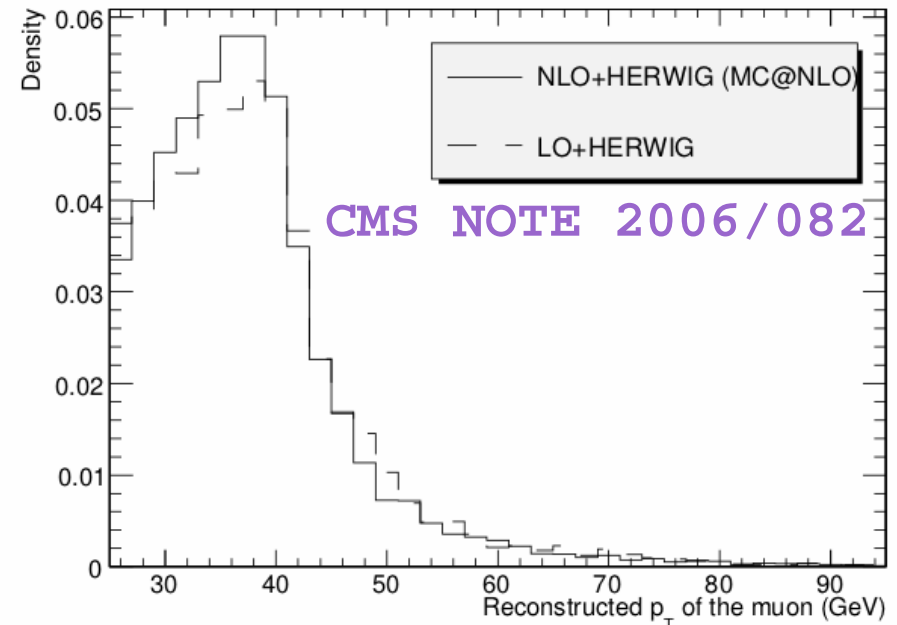
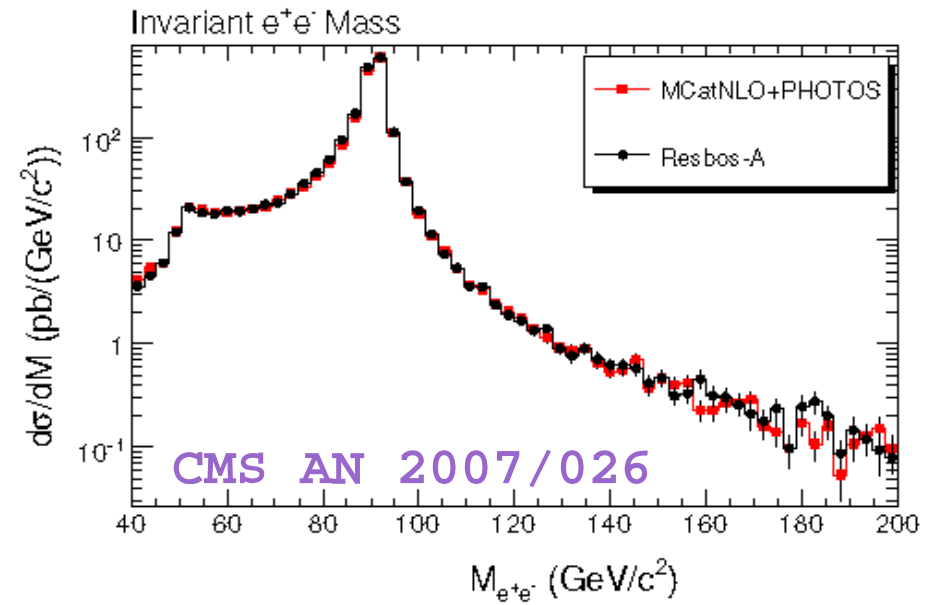


## Possible systematic effects

- bias in modelling QCD and signal templates
- biases from W and EWK events in the non-isolated electron sample
- accuracy in the MC prediction of EWK backgrounds

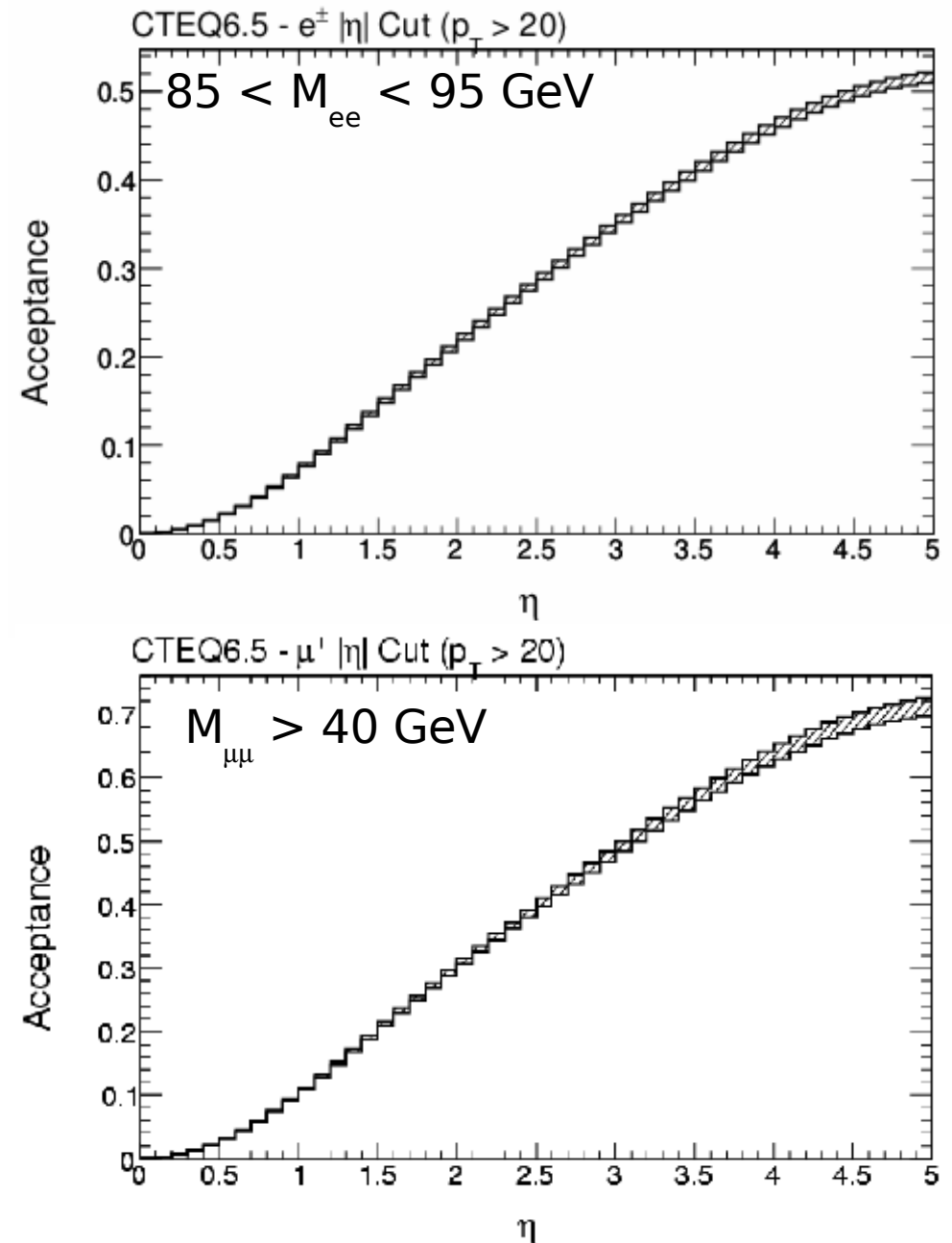
# Acceptance studies

- Comparisons between different generators and predictions (LO vs NLO)
- NLO QCD and EWK corrections
  - MC@NLO+PHOTOS vs RESBOS-A
  - HORACE vs LO MC + PHOTOS
  - using MC@NLO+PHOTOS  $\Rightarrow$  overall theoretical uncertainty on  $Z \rightarrow ll$  acceptance at the **percent level**
- $W \rightarrow l\nu$ 
  - LO – NLO (MC@NLO)  $\sim 2\%$  uncertainty on acceptance



# Acceptance uncertainty from PDFs

- uncertainty on acceptance in  $Z \rightarrow \ell\ell$  events from PDFs at the 1% level
  - evaluated with CTEQ6.5
  - $\sim 1\%$  difference between CTEQ6.5 central value and other MRST PDF sets



CMS AN 2007/031

CMS AN 2007/026

- W,Z inclusive cross section measurements will be one of the first measurements with early data
- Efforts to investigate strategies to measure most of the parameters from data and to minimize the dependence on Monte Carlo
- Trigger and offline efficiencies can be measured from data exploiting  $Z \rightarrow \ell\ell$  events
- QCD background estimation (shape and normalization) from data using different methods
- Residual dependences on MC: acceptance determination, electroweak backgrounds



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# Backup slides

# Trigger efficiency - electrons

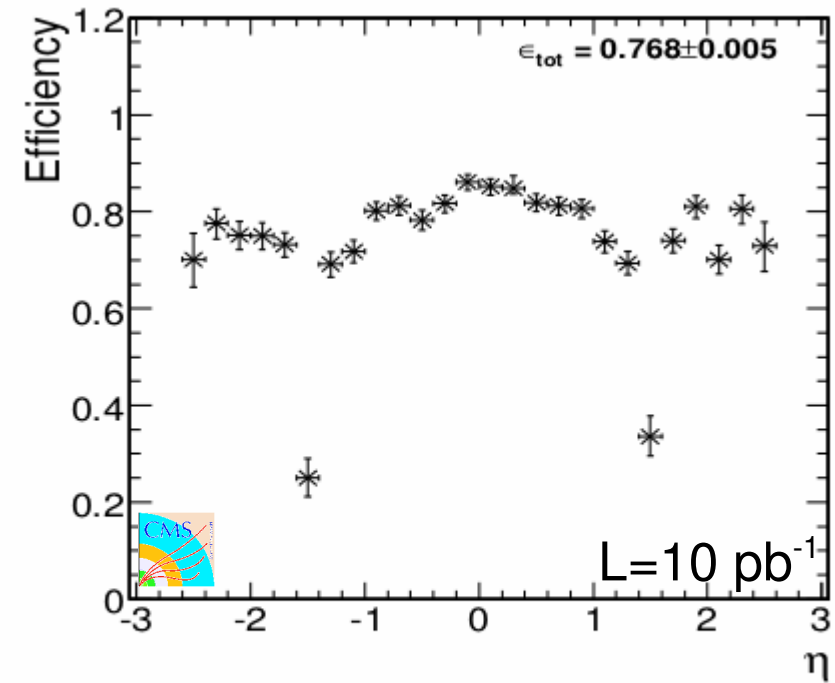
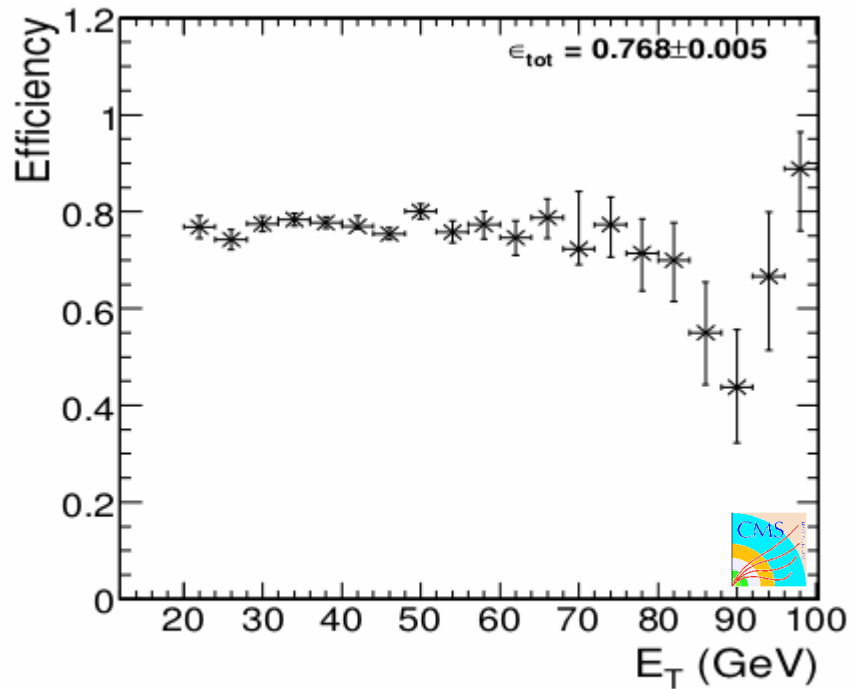
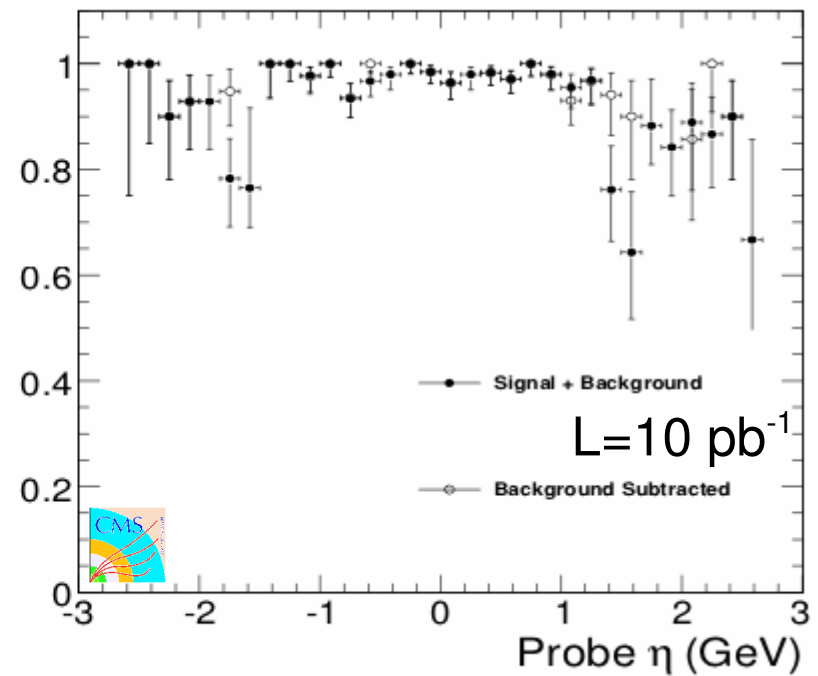
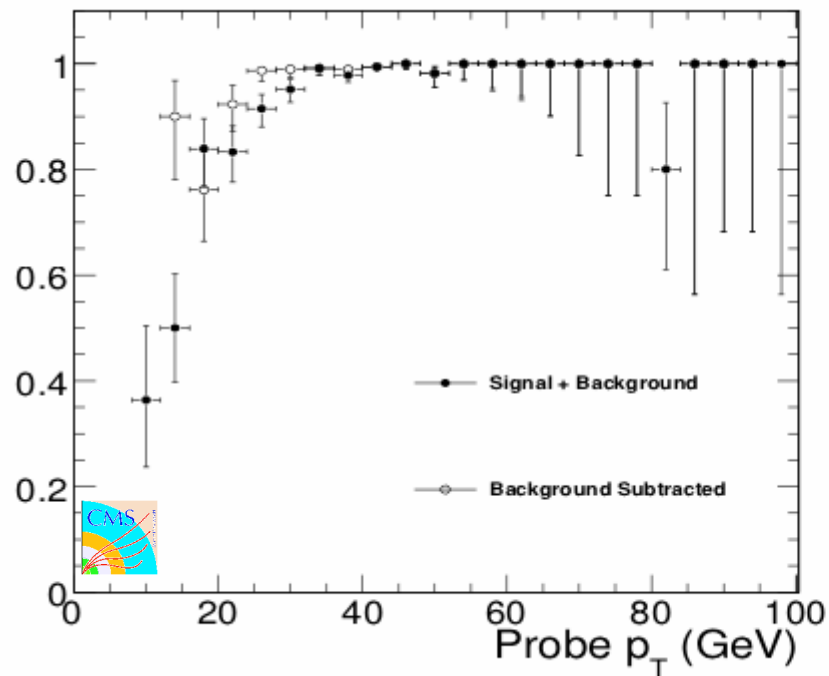


Figure 3: L1+HLT efficiency versus supercluster  $E_T$ .

Figure 4: L1+HLT efficiency versus supercluster  $\eta$ .

# Efficiency - electrons

Electromagnetic calorimeter reconstruction efficiency as a function of probe track  $p_T$ : comparison between signal+background and after background subtraction



# Muon momentum scale from Z

- use  $Z \rightarrow \mu\mu$  events to correct muon scale biases due to
  - effectiveness of the muon reconstruction procedure
  - imperfect knowledge of the detector conditions
- studied for  $10 \text{ pb}^{-1}$  with different scenarios
  - normal detector conditions
  - tracker misalignment
  - muon system misalignment
  - modified B-field intensity
- correct  $\mu$  scale as a function of muon kinematics:  $p^T = k \times p^T$  with  $k = F(p^T, \eta, \phi; \alpha \dots)$
- scale corrections improve also systematics on cross section measurements (acceptance uncertainties)

